

UCD3138 1/8th Brick Test Report

1.1 Transient Load

1A~11A step load, 1A/us slew rate, without oversampling

320mV overshoot, 346mV undershoot. Recover time: overshoot: 220us; undershoot: 410us



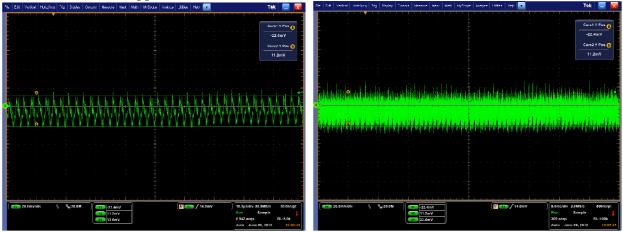
1A~11A step load, 1A/us slew rate, **x2 oversampling** 320mV overshoot, 346mV undershoot. Recover time: overshoot: 170us; undershoot: 330us





1.2 Output Ripple

Vin=48V, Io=0A /Ripple=33.6mV



Vin=48V, Io=10A /Ripple=28mV



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20.0	mV/div	′y ¶ _₩ :20.9M	20.6mV		(🛛 🐨 🖍 11.5r		1Sis 300ns/pt
			28.4mV			418 acqs Auto June 08	RL:100k





TEXAS INSTRUMENTS 1.3 Soft start



Soft start at 48V input, 0A load, with syncFETs on from the beginning

Soft start at 48V input, 10A load, with syncFETs on from the beginning



TEXAS INSTRUMENTS

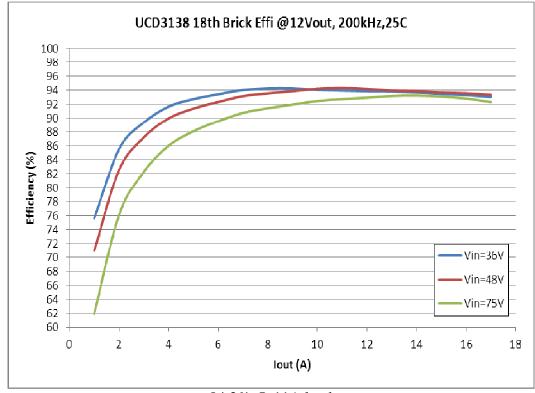
1.4 Pre-bias Start-up





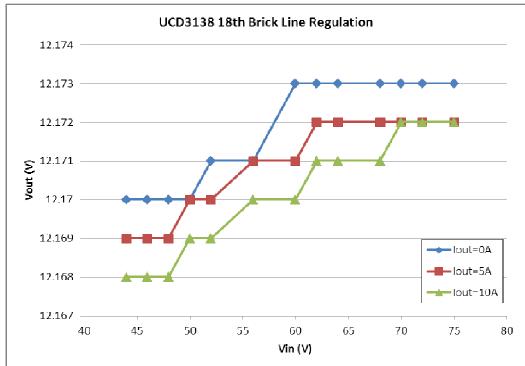
TEXAS INSTRUMENTS

1.5 Efficiency



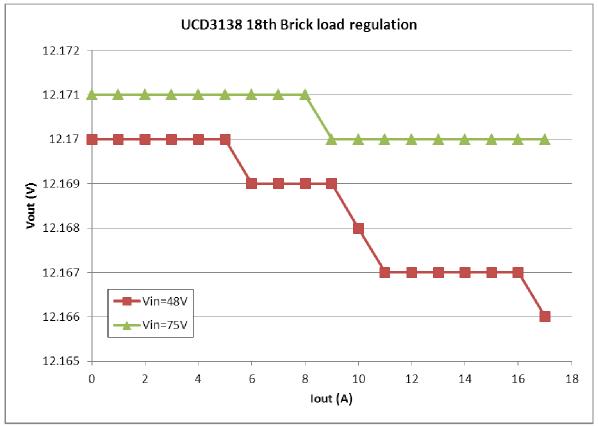
94.3% @ 11A load





TEXAS INSTRUMENTS





1.8 Constant Power Constant Current (CPCC)

TEXAS INSTRUMENTS

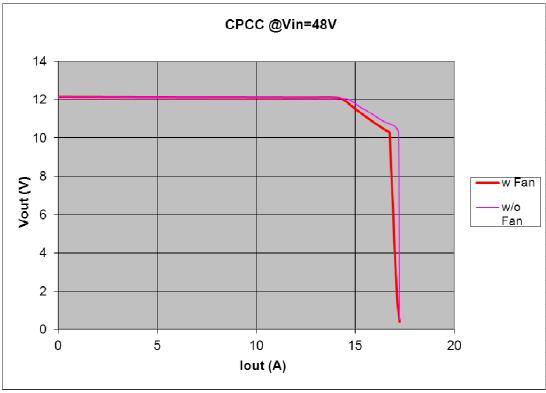


Figure 1 Constant Power Constant Current Test

1.9 Surge Test

Load 1A, Vin from 40V~60V, Vin slew rate 30.4V/2.36us. KP_COEFF_1 = 8000, KP_COEFF_2 = 10000 Vout variation 760mV, recover time 80us





Figure 2 Surge Test

TEXAS INSTRUMENTS

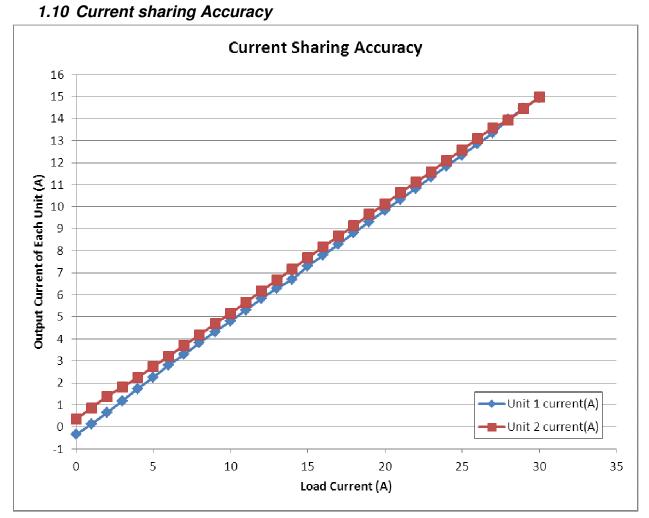


Figure 3 Current Sharing Accuracy



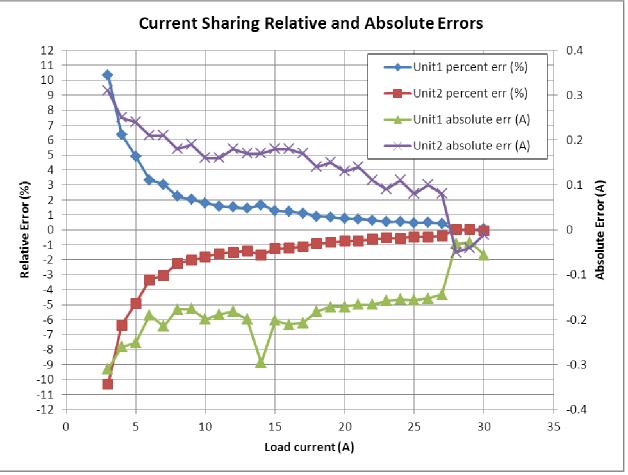


Figure 4 Current Sharing Relative and Absolute Errors

1.11 Copper Trace Current Sensing Accuracy

The measured copper trace current sending absolute error is -0.4A~0.6A. (Tested with temperature compensation only.)



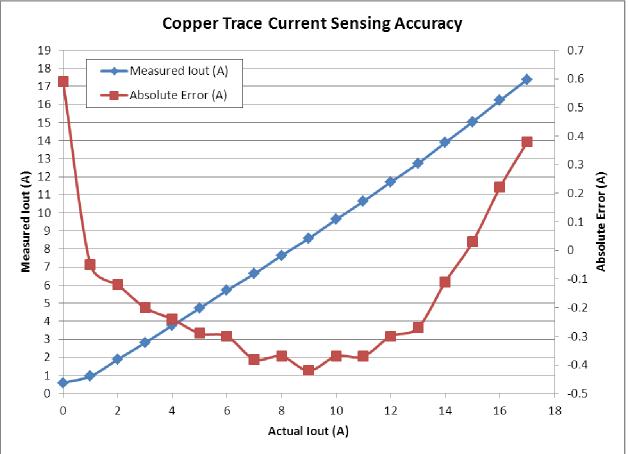


Figure 5 Copper Trace Current Sensing Accuracy



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